



#### **FEATURES**

- Member of the Texas Instruments Widebus™
   Family
- UBT<sup>™</sup> Transceiver Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Modes
- Operates From 1.65 V to 3.6 V
- Max t<sub>pd</sub> of 4.4 ns at 3.3 V
- ±12-mA Output Drive at 3.3 V
- Outputs Ports Have Equivalent 26- $\Omega$  Series Resistors, So No External Resistors Are Required
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

#### **DESCRIPTION/ORDERING INFORMATION**

This 18-bit universal bus transceiver is designed for 1.65-V to 3.6-V  $V_{\rm CC}$  operation.

The SN74ALVCHR16601 combines D-type latches and D-type flip-flops to allow data flow in transparent, latched, clocked, and clock-enabled modes.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. The clock can be controlled by the clock-enable (CLKENAB and CLKENBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. When OEAB is low, the outputs are active. When OEAB is high, the outputs are in the high-impedance state.

# DGG, DGV, OR DL PACKAGE (TOP VIEW)

		J	
OEAB	1 `	56	CLKENAB
LEAB [	2	55	CLKAB
A1 [	3	54	] B1
GND [	4	53	GND
A2 [	5		] B2
А3	6	51	] B3
V <sub>CC</sub>	7	50	] v <sub>cc</sub>
A4 [		49	] B4
A5 [	9	48	] B5
A6	10	47	] B6
GND [	11	46	GND
A7 [	12		] B7
A8 [	13	44	
A9 [	14	43	] B9
A10	15		B10
A11	16	41	] B11
A12	17	40	B12
GND [	18	39	GND
A13	19	38	B13
A14	20	37	B14
A15	21	36	B15
v <sub>cc</sub> [	22	35	] v <sub>cc</sub>
A16	23	34	
A17 [	24	33	] B17
GND [	25	32	GND
A18	26	31	B18
<b>OEBA</b>	27	30	CLKBA
LEBA [	28	29	CLKENBA

#### ORDERING INFORMATION

T <sub>A</sub>	PACKAGE(	1)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SSOP - DL	Tube	SN74ALVCHR16601DL	ALVCHR16601
40°C to 85°C	330P - DL	Tape and reel	SN74ALVCHR16601LR	ALVORKIOOUI
-40°C to 85°C	TSSOP - DGG	Tape and reel	SN74ALVCHR16601GR	ALVCHR16601
	TVSOP - DGV	Tape and reel	SN74ALVCHR16601VR	VR601

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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SCES123I-SEPTEMBER 1997-REVISED SEPTEMBER 2004



# **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

Data flow for B to A is similar to that of A to B, but uses OEBA, LEBA, CLKBA, and CLKENBA.

The outputs include equivalent  $26-\Omega$  series resistors to reduce overshoot and undershoot.

To ensure the high-impedance state during power up or power down,  $\overline{\text{OE}}$  should be tied to  $V_{\text{CC}}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

#### **FUNCTION TABLE**(1)

	INPUTS								
CLKENAB	OEAB	LEAB	CLKAB	Α	В				
Х	Н	Х	Х	Х	Z				
X	L	Н	X	L	L				
X	L	Н	X	Н	Н				
Н	L	L	X	X	B <sub>0</sub> <sup>(2)</sup>				
L	L	L	$\uparrow$	L	L				
L	L	L	$\uparrow$	Н	Н				
L	L	L	L or H	X	B <sub>0</sub> <sup>(2)</sup>				

- (1) A-to-B data flow is shown; B-to-A flow is similar, but uses  $\overline{\text{OEBA}}$ , LEBA, CLKBA, and  $\overline{\text{CLKENBA}}$ .
- (2) Output level before the indicated steady-state input conditions were established



# **LOGIC DIAGRAM (POSITIVE LOGIC)** OEAB 56 **CLKENAB CLKAB** LEAB 28 LEBA 30 CLKBA CLKENBA OEBA CE 1D В1 C1 CLK CE 1D C1 CLK <

# ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
.,	Land calls as as as	Except I/O ports (2)	-0.5	4.6	V
VI	Input voltage range	I/O ports <sup>(2)(3)</sup>	-0.5	$V_{CC} + 0.5$	V
Vo	Output voltage range <sup>(2)(3)</sup>		-0.5	$V_{CC} + 0.5$	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
l <sub>ok</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
lo	Continuous output current			±50	mA
	Continuous current through each V <sub>CC</sub> o	r GND		±100	mA
		DGG package		64	
$\theta_{JA}$	Package thermal impedance (4)	DGV package		48	°C/W
		DL package		56	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

To 17 Other Channels

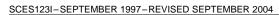
<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>3)</sup> This value is limited to 4.6 V maximum.

<sup>(4)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

# SN74ALVCHR16601 18-BIT UNIVERSAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS





# **RECOMMENDED OPERATING CONDITIONS**(1)

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		1.65	3.6	V	
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>			
$V_{IH}$	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2	2		
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		
$V_{IL}$	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7		
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		
VI	Input voltage		0	V <sub>CC</sub>	V	
Vo	Output voltage		0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 1.65 V		-2		
		V <sub>CC</sub> = 2.3 V		-6		
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 2.7 V	-8		mA	
		V <sub>CC</sub> = 3 V		-12		
		V <sub>CC</sub> = 1.65 V		2		
	Laur laurel autout aumant	V <sub>CC</sub> = 2.3 V		6	mA	
l <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		8		
		V <sub>CC</sub> = 3 V				
Δt/Δν	Input transition rise or fall rate			10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	85	°C	

<sup>(1)</sup> All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



# **SN74ALVCHR16601 18-BIT UNIVERSAL BUS TRANSCEIVER**

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### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN TYP(1) MAX	UNIT		
	I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2			
	I <sub>OH</sub> = -2 mA	1.65 V	1.2			
	I <sub>OH</sub> = -4 mA	2.3 V	1.9			
V <sub>OH</sub>	I 6 m A	2.3 V	1.7	V		
	$I_{OH} = -6 \text{ mA}$	3 V	2.4			
	I <sub>OH</sub> = -8 mA	2.7 V	2			
	I <sub>OH</sub> = -12 mA	3 V	2			
	$I_{OL} = 100 \mu A$	1.65 V to 3.6 V	0.2			
	I <sub>OL</sub> = 2 mA	1.65 V	0.45			
V <sub>OL</sub>	I <sub>OL</sub> = 4 mA	2.3 V	0.4	V		
	I 6 m A	2.3 V	0.55			
	$I_{OL} = 6 \text{ mA}$	3 V	0.55			
	I <sub>OL</sub> = 8 mA	2.7 V	0.6			
	I <sub>OL</sub> = 12 mA	3 V	0.8			
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.6 V	±5	μΑ		
	V <sub>I</sub> = 0.58 V	4.05.1/	25			
	V <sub>I</sub> = 1.07 V	1.65 V	-25			
	V <sub>I</sub> = 0.7 V	227	45			
I <sub>I(hold)</sub>	V <sub>I</sub> = 1.7 V	2.3 V	-45	μΑ		
	V <sub>I</sub> = 0.8 V	2.1/	75			
	V <sub>I</sub> = 2 V	3 V	-75			
	$V_1 = 0 \text{ to } 3.6 \text{ V}^{(2)}$	3.6 V	±500			
I <sub>OZ</sub> <sup>(3)</sup>	$V_O = V_{CC}$ or GND	3.6 V	±10	μΑ		
I <sub>CC</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V	40	μΑ		
$\Delta I_{CC}$	One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V	750	μΑ		
C <sub>i</sub> Control inputs	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V	4	pF		
C <sub>io</sub> A or B ports	$V_O = V_{CC}$ or GND	3.3 V	8	pF		

All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to

For I/O ports, the parameter  $I_{\text{OZ}}$  includes the input leakage current.

# SN74ALVCHR16601 18-BIT UNIVERSAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS

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#### **TIMING REQUIREMENTS**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

				V <sub>CC</sub> =	V <sub>CC</sub> = 1.8 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		$V_{CC}$ = 3.3 V $\pm$ 0.3 V	
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency				(1)		150		150		150	MHz
	t <sub>w</sub> Pulse duration	LE high		(1)		3.3		3.3		3.3		20
ı <sub>w</sub>		CLK high or low		(1)		3.3		3.3		3.3		ns
		Data before CLK↑		(1)		2.3		2.4		2.1		
	Catura tima	Data before LE↓	CLK high	(1)		2		1.6		1.6		ns
t <sub>su</sub>	Setup time		CLK low	(1)		1.3		1.2		1.1		
		CLKEN before CLK↑		(1)		2		2		1.7		
		Data after CLK↑		(1)		0.7		0.7		0.8		
	م الماما الأسمام	Data affaul E	CLK high	(1)		1.3		1.6		1.4		ns
t <sub>h</sub>	Hold time	ime Data after LE↓	CLK low	(1)		1.7		2		1.7		
		CLKEN after CLK↑		(1)		0.3		0.5		0.6		

<sup>(1)</sup> This information was not available at the time of publication.

#### **SWITCHING CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	V <sub>CC</sub> =	1.8 V	V <sub>CC</sub> = ± 0.2	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 3 ± 0.3	3.3 V 3 V	UNIT
	(INPUT)	(001F01)	MIN	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			(1)		150		150		150		MHz
	A or B			(1)	1	4.8		5.1	1	4.4	
t <sub>pd</sub>	LEAB or LEBA	B or A		(1)	1	5.5		5.8	1	5.1	ns
	CLKAB or CLKBA			(1)	1.2	5.9		6.3	1.4	5.4	
t <sub>en</sub>	OEAB or OEBA	B or A		(1)	1.1	6.3		6.6	1.1	5.6	ns
t <sub>dis</sub>	OEAB or OEBA	B or A		(1)	1	4.2		5.1	1.6	4.7	ns

<sup>(1)</sup> This information was not available at the time of publication.

#### **OPERATING CHARACTERISTICS**

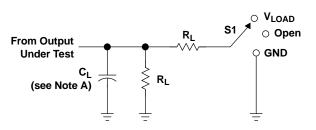
 $T_A = 25^{\circ}C$ 

PARAMETER		TEST CONDITIONS		V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT	
_	Power dissipation	Outputs enabled	C - 0	f = 10 MHz	(1)	56	63	nE
Cpd	capacitance	Outputs disabled	$C_L = 0$ ,	I = IO MINZ	(1)	12	13	p⊦

<sup>(1)</sup> This information was not available at the time of publication.



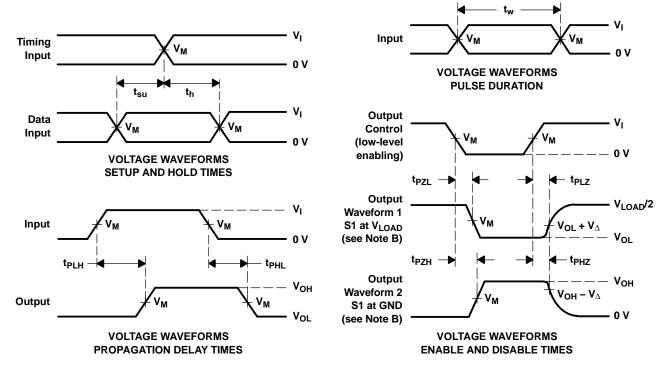
#### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>pd</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

**LOAD CIRCUIT** 

v	INPUT		V	v		6	v
V <sub>CC</sub>	VI	V <sub>I</sub> V <sub>LOAD</sub>		CL	R <sub>L</sub>	$oldsymbol{V}_\Delta$	
1.8 V	V <sub>CC</sub>	≤ <b>2</b> ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_{O} = 50 \Omega$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms







#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74ALVCHR16601DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCHR16601GRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCHR16601GRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCHR16601LRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCHR16601VRE4	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVCHR16601VRG4	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCHR16601DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCHR16601GR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCHR16601LR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVCHR16601VR	ACTIVE	TVSOP	DGV	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVCHR16601GR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74ALVCHR16601LR	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1
SN74ALVCHR16601VR	TVSOP	DGV	56	2000	330.0	24.4	6.8	11.7	1.6	12.0	24.0	Q1





\*All dimensions are nominal

7 til dillionolollo alo nominal							
Device	Package Type Package Drawing		Pins SPQ		Length (mm)	Width (mm)	Height (mm)
SN74ALVCHR16601GR	TSSOP	DGG	56	2000	346.0	346.0	41.0
SN74ALVCHR16601LR	SSOP	DL	56	1000	346.0	346.0	49.0
SN74ALVCHR16601VR	TVSOP	DGV	56	2000	346.0	346.0	41.0

# DGG (R-PDSO-G\*\*)

# PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

### DL (R-PDSO-G\*\*)

#### **48 PINS SHOWN**

#### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

# DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



# PACKAGE OPTION ADDENDUM

10-Dec-2020

#### **PACKAGING INFORMATION**

www.ti.com

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74ALVCHR16601DL	ACTIVE	SSOP	DL	56	20	RoHS & Green	(6) NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCHR16601	Samples
SN74ALVCHR16601GR	ACTIVE	TSSOP	DGG	56	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCHR16601	Samples
SN74ALVCHR16601LR	ACTIVE	SSOP	DL	56	1000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCHR16601	
SN74ALVCHR16601VR	ACTIVE	TVSOP	DGV	56	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	VR601	Samples Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE OPTION ADDENDUM

10-Dec-2020

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# TAPE AND REEL INFORMATION





Α0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ALVCHR16601GR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74ALVCHR16601LR	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1
SN74ALVCHR16601VR	TVSOP	DGV	56	2000	330.0	24.4	6.8	11.7	1.6	12.0	24.0	Q1

**PACKAGE MATERIALS INFORMATION** 

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\*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ALVCHR16601GR	TSSOP	DGG	56	2000	367.0	367.0	45.0
SN74ALVCHR16601LR	SSOP	DL	56	1000	367.0	367.0	55.0
SN74ALVCHR16601VR	TVSOP	DGV	56	2000	367.0	367.0	45.0

# PACKAGE MATERIALS INFORMATION

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### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74ALVCHR16601DL	DL	SSOP	56	20	473.7	14.24	5110	7.87

# DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



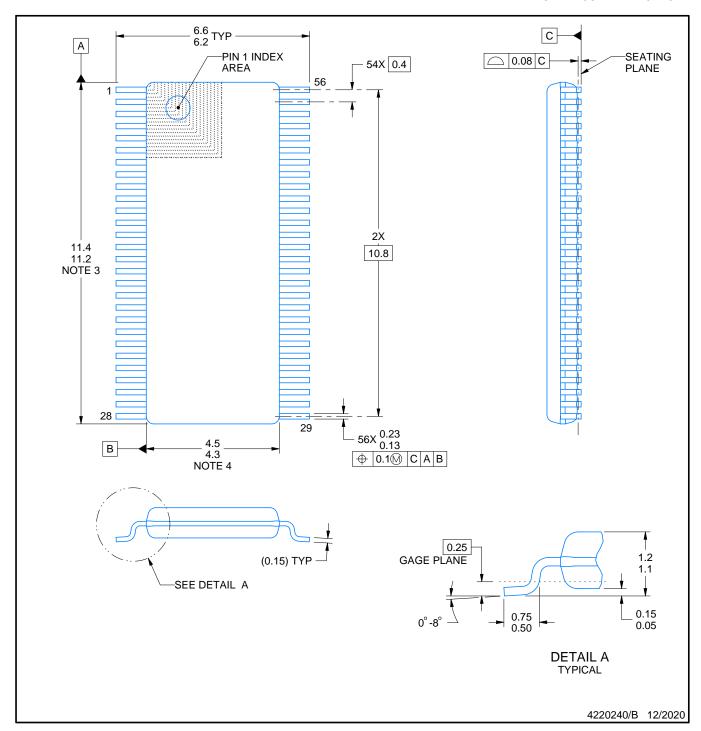
NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194





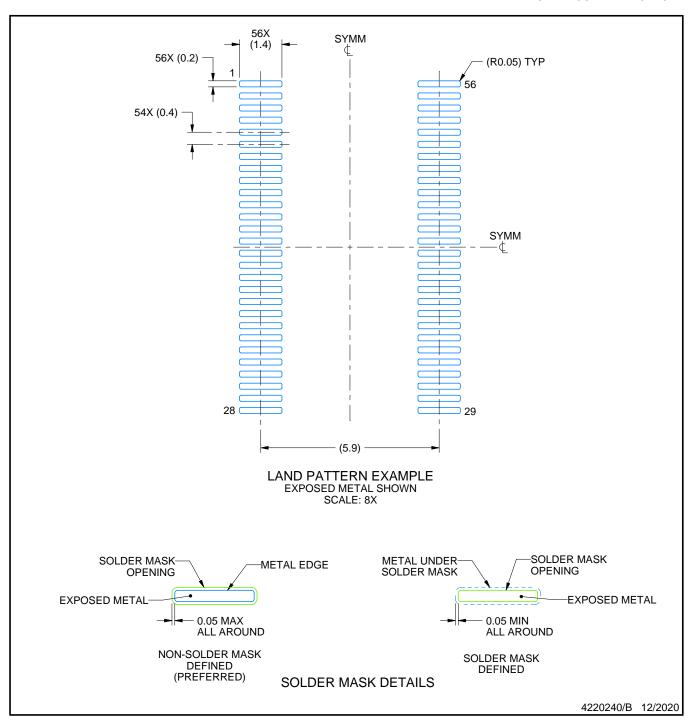
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-194.



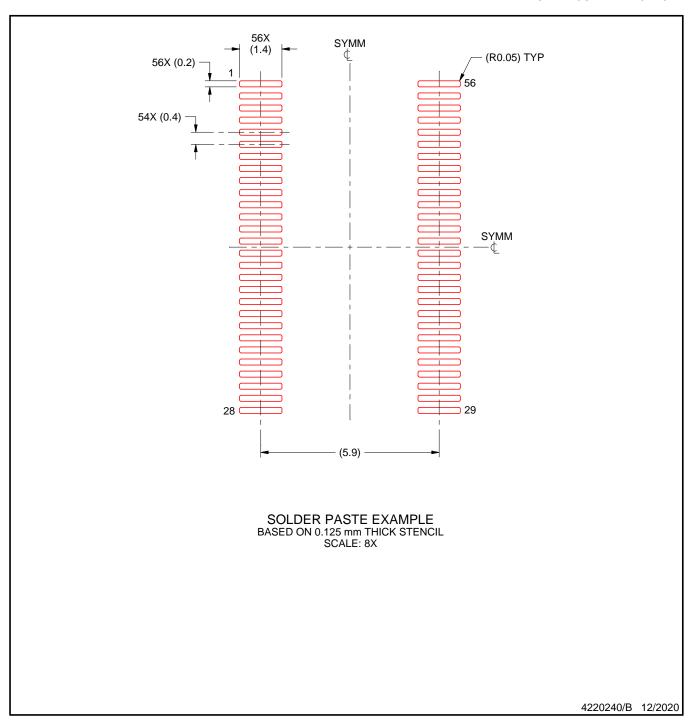


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# DL (R-PDSO-G56)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

PowerPAD is a trademark of Texas Instruments.







#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-153.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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